

STD60NF06

N-CHANNEL 60V - 0.014Ω - 60A DPAK STripFET™ II POWER MOSFET

TYPE	V _{DSS}	R _{DS(on)}	I _D
STD60NF06	60 V	< 0.016 Ω	60A

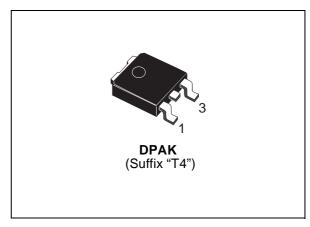
- TYPICAL $R_{DS}(on) = 0.014\Omega$
- EXCEPTIONAL dv/dt CAPABILITY
- 100% AVALANCHE TESTED
- APPLICATION ORIENTED CHARACTERIZATION

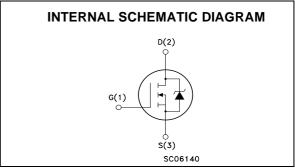
DESCRIPTION

This Power Mosfet series realized with STMicroelectronics unique STripFET process has specifically been designed to minimize input capacitance and gate charge. It is therefore suitable as primary switch in advanced high-efficiency isolated DC-DC converters for Telecom and Computer application. It is also intended for any application with low gate charge drive requirements.

APPLICATIONS

- HIGH-EFFICIENCY DC-DC CONVERTERS
- UPS AND MOTOR CONTROL
- AUTOMOTIVE





ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit	
V _{DS}	Drain-source Voltage (V _{GS} = 0)	60	V	
V_{DGR}	Drain-gate Voltage ($R_{GS} = 20 \text{ k}\Omega$)	60	V	
V _{GS}	Gate- source Voltage	± 20	V	
I _D	Drain Current (continuous) at T _C = 25°C	60	А	
I _D	Drain Current (continuous) at T _C = 100°C	42	А	
I _{DM} (●)	Drain Current (pulsed)	240	А	
P _{TOT}	Total Dissipation at T _C = 25°C	110	W	
	Derating Factor	0.73	W/°C	
dv/dt (1)	Peak Diode Recovery voltage slope	4	V/ns	
T _{stg}	Storage Temperature	- 55 to 175	°C	
Tj	Operating Junction Temperature	- 55 10 175		

^(•) Pulse width limited by safe operating area

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⁽¹⁾ I_{SD}≤ 60A, di/dt≤200 A/μs, V_{DD}≤ 24V, Tj≤T_{jMAX}

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THERMAL DATA

Rthj-case	Thermal Resistance Junction-case Max	1.36	°C/W
Rthj-amb	Thermal Resistance Junction-ambient Max	100	°C/W
T _I	Maximum Lead Temperature For Soldering Purpose	275	°C

AVALANCHE CHARACTERISTICS

Symbol	Parameter	Max Value	Unit
I _{AR}	Avalanche Current, Repetitive or Not-Repetitive (pulse width limited by T_j max)	30	Α
E _{AS}	Single Pulse Avalanche Energy (starting $T_j = 25$ °C, $I_D = I_{AR}$, $V_{DD} = 30$ V)	350	mJ

ELECTRICAL CHARACTERISTICS (T_{CASE} = 25 °C UNLESS OTHERWISE SPECIFIED) OFF

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source Breakdown Voltage	$I_D = 250 \ \mu A, \ V_{GS} = 0$	60			V
I _{DSS}	Zero Gate Voltage	V _{DS} = Max Rating			1	μA
	Drain Current (V _{GS} = 0)	V _{DS} = Max Rating, T _C = 125 °C			10	μΑ
I _{GSS}	Gate-body Leakage Current (V _{DS} = 0)	V _{GS} = ± 20V			±100	nA

ON (1)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2		4	V
R _{DS(on)}	Static Drain-source On Resistance	V _{GS} = 10 V, I _D = 30 A		0.014	0.016	Ω

DYNAMIC

Symbol	Parameter	Test Conditions Min.		Тур.	Max.	Unit
g _{fs} (1)	Forward Transconductance	V _{DS} =15 V , I _D = 30 A		20		S
C _{iss}	Input Capacitance	$V_{DS} = 25 \text{ V, f} = 1 \text{ MHz, } V_{GS} = 0$		1810		pF
Coss	Output Capacitance			360		pF
C _{rss}	Reverse Transfer Capacitance			125		pF

ELECTRICAL CHARACTERISTICS (CONTINUED)

SWITCHING ON

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on Delay Time	V _{DD} = 30 V, I _D = 30 A		16		ns
t _r	Rise Time	$R_G = 4.7\Omega$, $V_{GS} = 10 \text{ V}$ (see test circuit, Figure 3)		108		ns
Qg	Total Gate Charge	V _{DD} = 48 V, I _D =60 A V _{GS} = 10 V		49	66	nC
Q_{gs}	Gate-Source Charge			18		nC
Q_{gd}	Gate-Drain Charge			14		nC

SWITCHING OFF

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
t _{d(off)} t _f	Turn-off-Delay Time Fall Time	V_{DD} = 30 V, I_D = 30 A, R_G = 4.7 Ω , V_{GS} = 10 V (see test circuit, Figure 3)		43 20		ns ns
$t_{ ext{d(off)}} \ t_{ ext{f}} \ t_{ ext{c}}$	Off-voltage Rise Time Fall Time Cross-over Time	Vclamp =48 V, I_D = 60 A R_G = 4.7 Ω , V_{GS} = 10 V (see test circuit, Figure 3)		40 12 21		ns ns ns

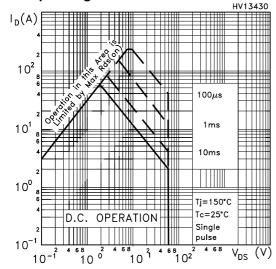
SOURCE DRAIN DIODE

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain Current				60	Α
I _{SDM} (2)	Source-drain Current (pulsed)				240	Α
V _{SD} (1)	Forward On Voltage	I _{SD} = 60 A, V _{GS} = 0			1.3	V
t _{rr} Q _{rr} I _{RRM}	Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Current	$I_{SD} = 60 \text{ A}$, $di/dt = 100 \text{A/}\mu\text{s}$, $V_{DD} = 25 \text{V}$, $T_j = 150 ^{\circ}\text{C}$ (see test circuit, Figure 5)		73 182 5		ns nC A

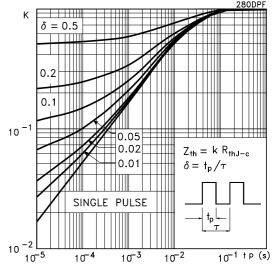
Note: 1. Pulsed: Pulse duration = 300 μs, duty cycle 1.5 %.
2. Pulse width limited by safe operating area.

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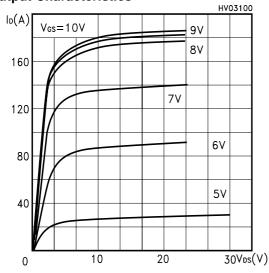
Safe Operating Area for DPAK



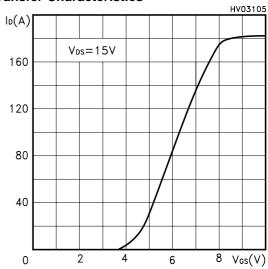
Thermal Impedence for DPAK



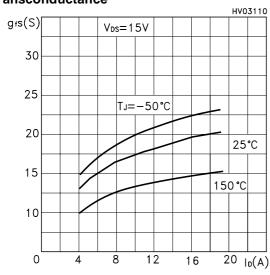
Output Characteristics



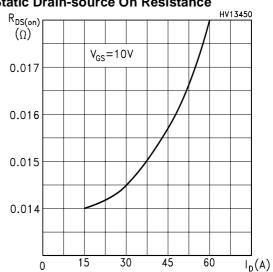
Transfer Characteristics



Transconductance

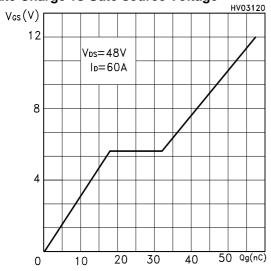


Static Drain-source On Resistance

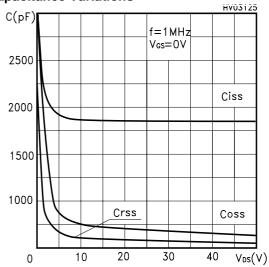


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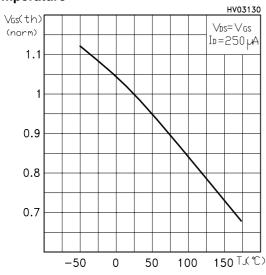
Gate Charge vs Gate-source Voltage



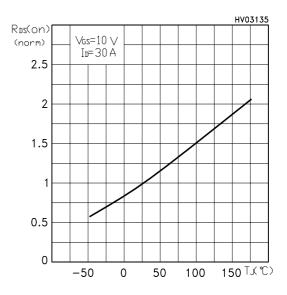
Capacitance Variations



Normalized Gate Threshold Voltage vs Temperature



Normalized On Resistance vs Temperature



Source-drain Diode Forward Characteristics

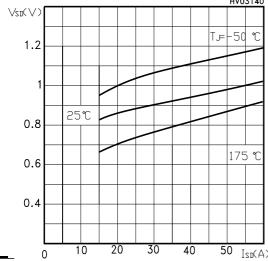


Fig. 1: Unclamped Inductive Load Test Circuit

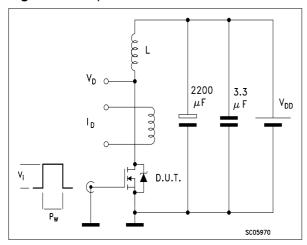


Fig. 3: Switching Times Test Circuit For Resistive Load

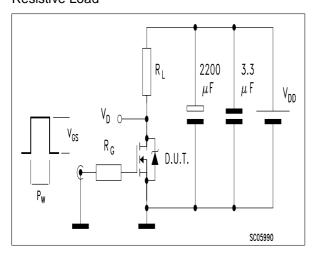


Fig. 5: Test Circuit For Inductive Load Switching And Diode Recovery Times

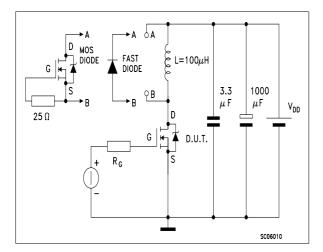


Fig. 2: Unclamped Inductive Waveform

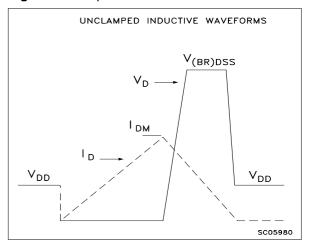
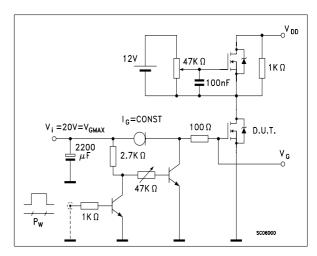
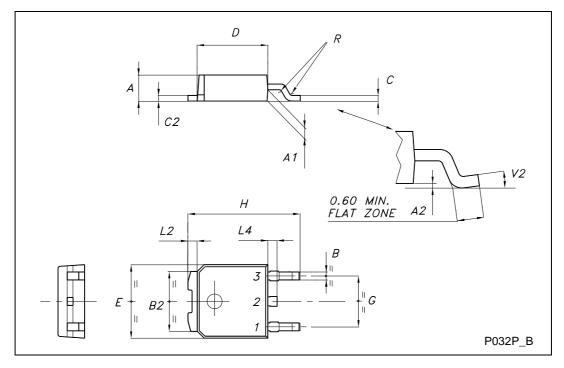


Fig. 4: Gate Charge test Circuit



TO-252 (DPAK) MECHANICAL DATA

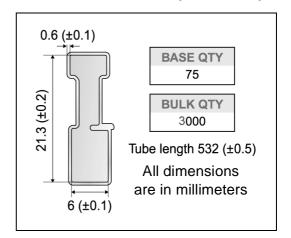
DIM.		mm			inch	
DIWI.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
А	2.20		2.40	0.087		0.094
A1	0.90		1.10	0.035		0.043
A2	0.03		0.23	0.001		0.009
В	0.64		0.90	0.025		0.035
B2	5.20		5.40	0.204		0.213
С	0.45		0.60	0.018		0.024
C2	0.48		0.60	0.019		0.024
D	6.00		6.20	0.236		0.244
Е	6.40		6.60	0.252		0.260
G	4.40		4.60	0.173		0.181
Н	9.35		10.10	0.368		0.398
L2		0.8			0.031	
L4	0.60		1.00	0.024		0.039
V2	0°		8°	0°		0°



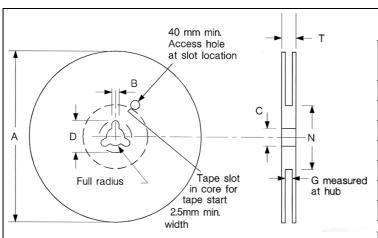
DPAK FOOTPRINT

6.7 1.8 3.0 1.6 2.3 1.6 All dimensions are in millimeters

TUBE SHIPMENT (no suffix)*



TAPE AND REEL SHIPMENT (suffix "T4")*

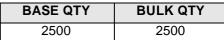


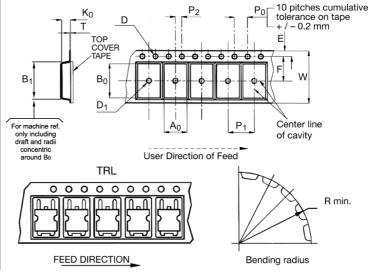
REEL MECHANICAL DATA

DIM.	mm		in	ch
DIIVI.	MIN.	N. MAX. MIN.		MAX.
Α		330		12.992
В	1.5		0.059	
С	12.8	13.2	0.504	0.520
D	20.2		0.795	
G	16.4	18.4	0.645	0.724
N	50		1.968	
Т		22.4		0.881

TAPE MECHANICAL DATA

DIM.	mm		inch	
	MIN.	MAX.	MIN.	MAX.
A0	6.8	7	0.267	0.275
В0	10.4	10.6	0.409	0.417
B1		12.1		0.476
D	1.5	1.6	0.059	0.063
D1	1.5		0.059	
E	1.65	1.85	0.065	0.073
F	7.4	7.6	0.291	0.299
K0	2.55	2.75	0.100	0.108
P0	3.9	4.1	0.153	0.161
P1	7.9	8.1	0.311	0.319
P2	1.9	2.1	0.075	0.082
R	40		1.574	
W	15.7	16.3	0.618	0.641





* on sales type

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